


<b>Search Notes</b>  	<b>Application/Control No.</b>  09845960	<b>Applicant(s)/Patent Under Reexamination</b>  TAKIGUCHI ET AL.
	<b>Examiner</b>  Phu K Nguyen	<b>Art Unit</b>  2628

SEARCHED			
Class	Subclass	Date	Examiner
345	419, 427, 428, 473, 474, 475, 581, 660, 661, 663, 664, 963	9/30/08	pn
715	739, 788, 839	9/30/08	pn

SEARCH NOTES		
Search Notes	Date	Examiner
WEST search: hierarchical, file, items, overlap	9/30/08	pn
NonPatent Literature: IEEE, ACM, Google	9/30/08	pn
Inventor Name search	9/30/08	pn

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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